

Notice of References Cited	Application/Control No. 10/594,426		Applicant(s)/Patent Under Reexamination ADACHI ET AL.	
	Examiner DAVID T. WELCH		Art Unit 2628	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,282,490 B1	08-2001	Nimura et al.	340/995.14
*	C	US-2004/0176908 A1	09-2004	Senda et al.	701/211
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	K	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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